

ULTIMATE PRECISION OF DIRECT TOMOGRAPHY OF WAVE FUNCTIONS

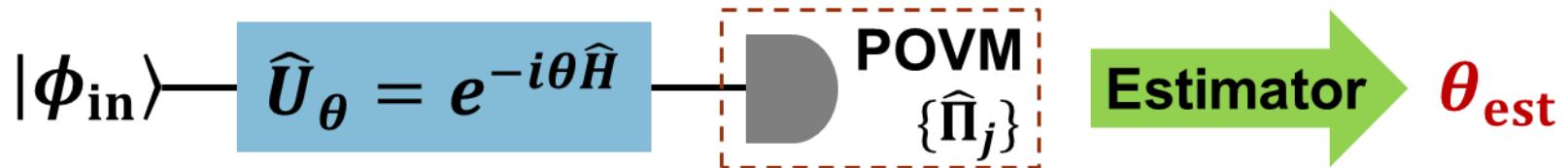
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OUTLINE

1. Parameter estimation
2. Direct tomography of the wave function
3. Ultimate precision of dicrect tomography
4. Summary

1. PARAMETER ESTIMATION



The bound of unbiased estimate:

$$(\Delta\theta_{\text{est}})^2 := \langle (\theta_{\text{est}} - \theta)^2 \rangle \geq \frac{1}{NF(\{\hat{\Pi}_j\})}$$

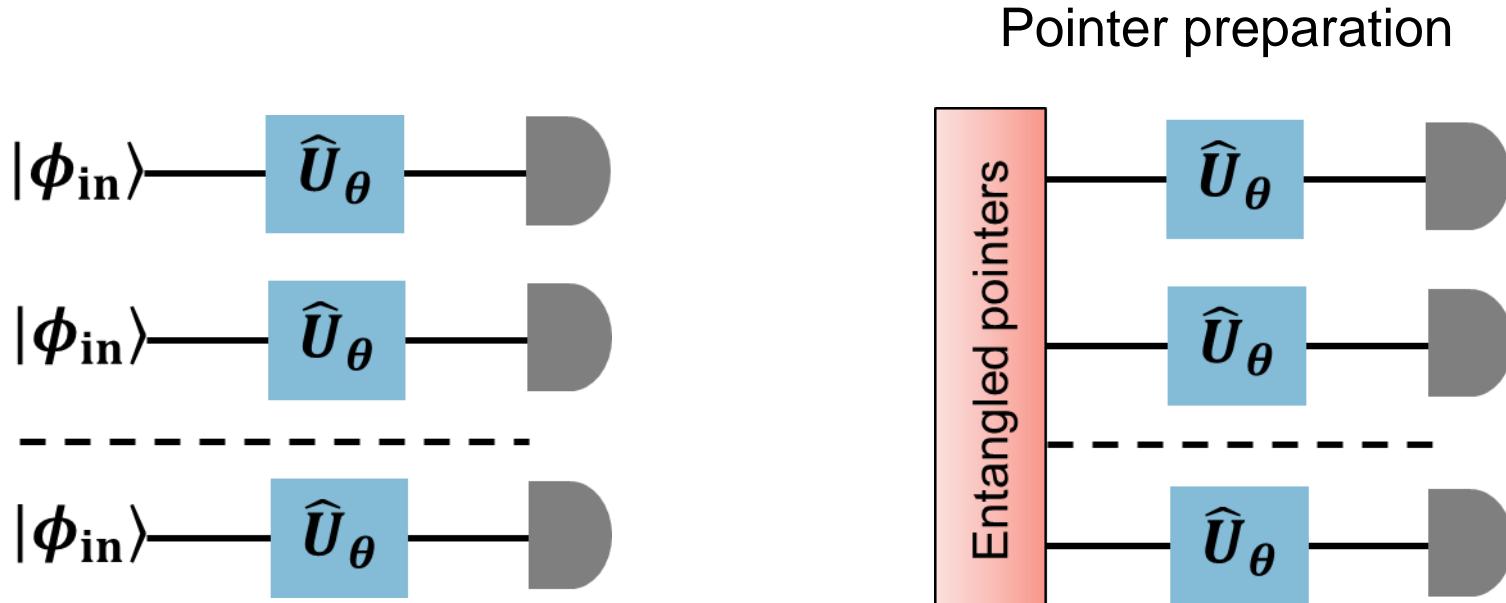
$$F(\{\hat{\Pi}_j\}) = \sum_j \frac{(\partial p_j / \partial \theta)^2}{p_j} \quad \text{Fisher information}$$

N : number of repetitions of experiment

$\{p_j\}$: probability distribution of $\{\hat{\Pi}_j\}$

1. PARAMETER ESTIMATION

Quantum-enhanced metrology



$$(\Delta\theta_{est})^2 \sim \frac{1}{N}$$

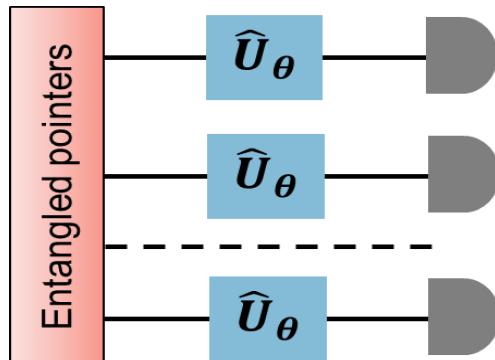
Standard quantum limit

$$(\Delta\theta_{est})^2 \sim \frac{1}{N^2}$$

Heisenberg limit

1. PARAMETER ESTIMATION

Quantum-enhanced metrology



$$\begin{aligned}|0\rangle &\rightarrow |0\rangle \\|1\rangle &\rightarrow e^{i\theta}|1\rangle\end{aligned}$$

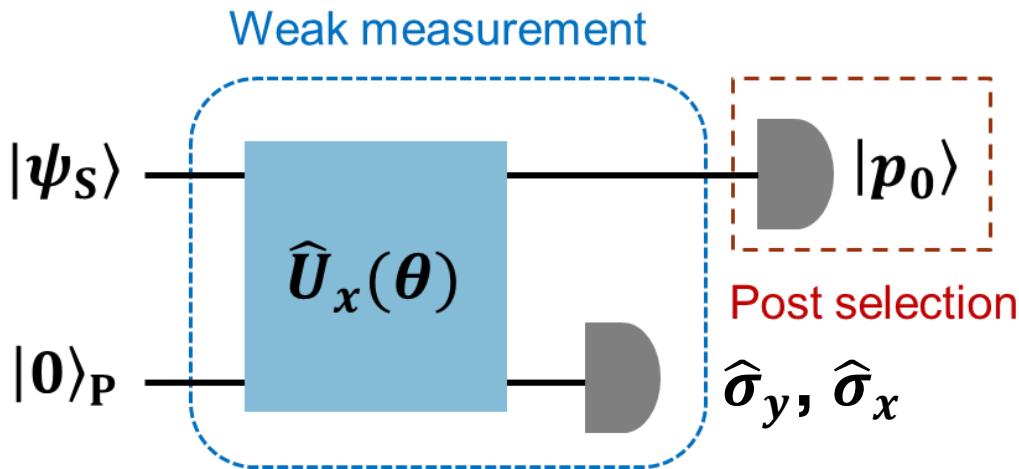
$$|\phi_{in}\rangle = \frac{|0\rangle^{\otimes N} + |1\rangle^{\otimes N}}{\sqrt{2}} \rightarrow |\phi_{out}\rangle = \frac{|0\rangle^{\otimes N} + e^{iN\theta}|1\rangle^{\otimes N}}{\sqrt{2}}$$

Measure $\hat{\sigma}_x$ on each probe (LOCC strategy)

$$\begin{aligned}\langle \hat{\sigma}_x^{\otimes N} \rangle &= \cos(N\theta) \\ \rightarrow (\Delta\theta)^2 &= \frac{1}{N^2}\end{aligned}$$

2. DIRECT TOMOGRAPHY

Measure wave function directly based on **weak measurement**



$$|\psi_S\rangle = \sum_{x=1}^d \psi_x |x\rangle$$
$$\hat{U}_x = e^{-i\theta \hat{\Pi}_x \otimes \hat{\sigma}_y}$$
$$\approx \hat{I}_P - i\theta \hat{\Pi}_x \otimes \hat{\sigma}_y$$
$$|\psi_0\rangle = \frac{1}{\sqrt{d}} \sum_{x=1}^d |x\rangle$$

$$\langle \hat{\Pi}_x \rangle_w = \frac{\langle \psi_0 | x \rangle \langle x | \psi_S \rangle}{\langle \psi_0 | \psi_S \rangle} = k \psi_x$$

$$k = 1/\tilde{\psi}$$
$$\tilde{\psi} = \sum_x \psi_x$$

→ tomography of two-dimension state

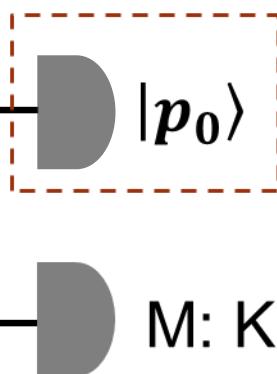
2. DIRECT TOMOGRAPHY

Measure wavefunction directly
No weak-coupling approximation

$$|\psi_s\rangle = \sum_{x=1}^d \psi_x |x\rangle$$

$$|\psi_s\rangle \xrightarrow{\widehat{U}_x(\theta)} |\psi_s\rangle$$

$$|\phi_{\text{in}}\rangle \xrightarrow{\widehat{U}_x(\theta)} M: K, K_1, K_2$$



$$\widehat{U}_x = e^{-i\theta \widehat{\Pi}_x \otimes \widehat{K}/2}$$

$$|p_0\rangle = \frac{1}{\sqrt{d}} \sum |x\rangle$$

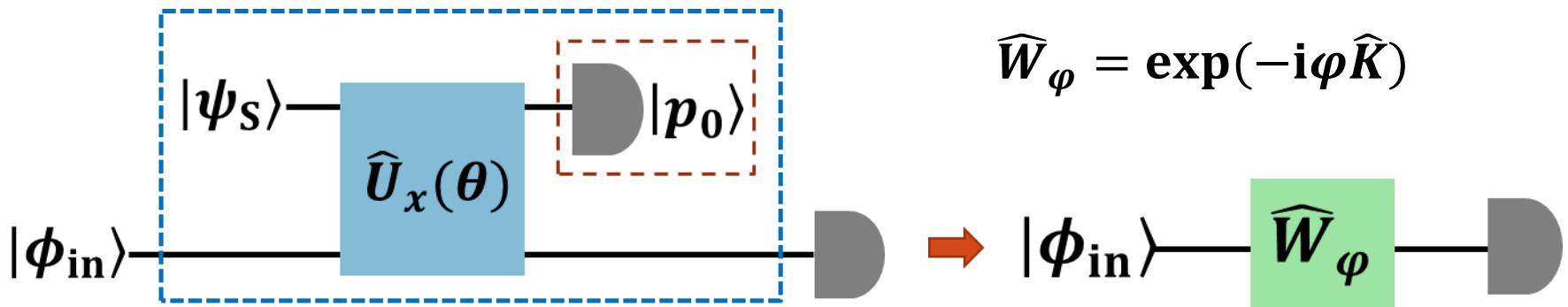
$\widehat{K}, \widehat{K}_1, \widehat{K}_2$: Pauli operators

$$\psi_x = \frac{d}{\tilde{\psi} \sin \theta} \left[\left((1 - P_{K_1}) \tan \frac{\theta}{2} + P_{K_2} - \frac{1}{2} \right) + i \left(P_K - \frac{1}{2} \right) \right]$$

$$\tilde{\psi} = \sum_x \psi_x, \quad P_M: \text{probability of measurement outcome 1}$$

2. DIRECT TOMOGRAPHY

as a complex-valued parameter estimation



Final pointer state: $|\phi_f\rangle \propto \hat{W}_\varphi |\phi_{in}\rangle$ $\varphi \in \mathbb{C}$

Relation between ψ_x and φ :

$$\frac{\psi_x}{\tilde{\psi}} = \frac{\tan(\varphi/2)}{2\sin(\theta/2)[\cos(\theta/4) + \sin(\theta/4)\tan(\varphi/2)]}$$

2. DIRECT TOMOGRAPHY

Estimation of complex parameter

- The real part:

$$\begin{bmatrix} \langle \hat{K}_1 \rangle_f \\ \langle \hat{K}_2 \rangle_f \end{bmatrix} \propto \begin{bmatrix} \cos(\operatorname{Re}\varphi) & -\sin(\operatorname{Re}\varphi) \\ \sin(\operatorname{Re}\varphi) & \cos(\operatorname{Re}\varphi) \end{bmatrix} \begin{bmatrix} \langle \hat{K}_1 \rangle_{in} \\ \langle \hat{K}_2 \rangle_{in} \end{bmatrix}$$

- The imaginary part:

$$\langle \hat{K} \rangle_f = \frac{\sinh(\operatorname{Im}\varphi) + \cosh(\operatorname{Im}\varphi)\langle \hat{K} \rangle_{in}}{\cosh(\operatorname{Im}\varphi) + \sinh(\operatorname{Im}\varphi)\langle \hat{K} \rangle_{in}}$$

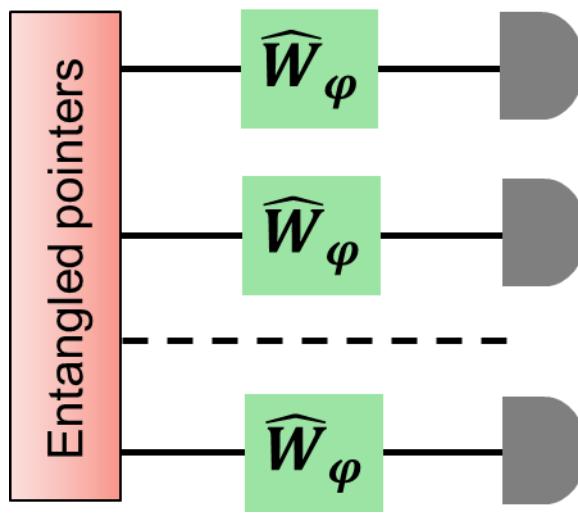
If $\langle \hat{K} \rangle_{in} = \langle \hat{K}_2 \rangle_{in} = 0$, two measurements are enough

$$\langle \hat{K}_1 \rangle_f = \frac{\cos(\operatorname{Re}\varphi)}{\cosh(\operatorname{Im}\varphi)} \langle \hat{K}_1 \rangle_{in}, \quad \langle \hat{K} \rangle_f = \frac{1}{2} \tanh(\operatorname{Im}\varphi)$$

2. DIRECT TOMOGRAPHY

Estimation of complex parameter

$$\varphi \in \mathbb{C}$$



Cramer-Rao bound
for multi-parameter estimate

$$C(\vec{X}) \geq \mathcal{F}^{-1}(\{\widehat{\Pi}_j\})$$

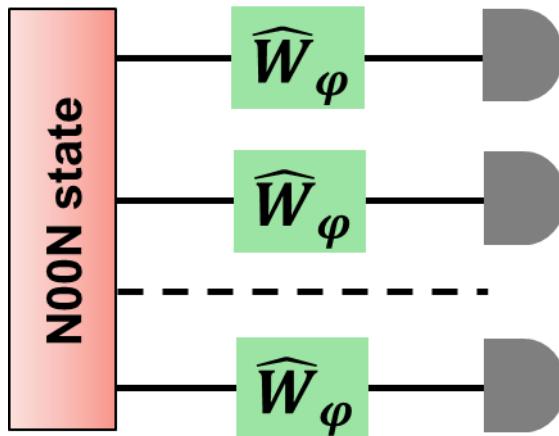
- Variance matrix: $C_{\mu\nu}(\vec{X}) = (\Delta X_\mu \Delta X_\nu)$
- Fisher information matrix:

$$\mathcal{F}_{\mu\nu} = \sum_j \frac{1}{p_j} \left(\frac{\partial p_j}{\partial X_\mu} \right) \left(\frac{\partial p_j}{\partial X_\nu} \right)$$

$(\Delta\varphi_{\text{est}})^2 \sim \frac{1}{N^2}$: Heisenberg limit?

3. ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 1a: Pointers are in NOON state $|\phi_{in}\rangle = \frac{1}{\sqrt{2}}(|0\rangle^{\otimes N} + |1\rangle^{\otimes N})$



Final pointer

$$|\phi_f\rangle_{\text{NOON}} = a|0\rangle^{\otimes N} + b e^{iN\text{Re}\varphi}|1\rangle^{\otimes N}$$

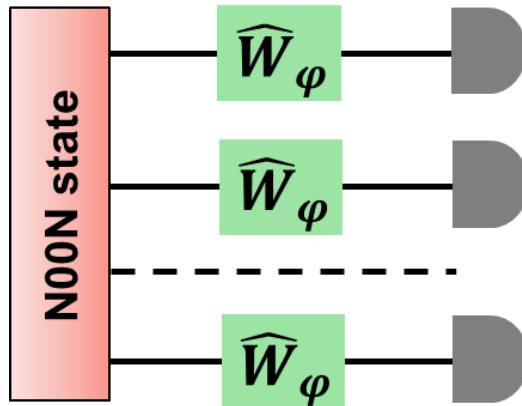
$$\text{where } a^2 - b^2 = \tanh(N\text{Im}\varphi)$$

$$\widehat{W}_\varphi = \exp(-i\varphi\hat{\sigma}_z/2), \varphi \in \mathbb{C}$$

- Measure $\hat{\sigma}_x$ to estimate $\text{Re}\varphi$
- Measure $\hat{\sigma}_z$ to estimate $\text{Im}\varphi$

3. ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 1a: Pointers are in NOON state $|\phi_{in}\rangle = \frac{1}{\sqrt{2}}(|0\rangle^{\otimes N} + |1\rangle^{\otimes N})$



Heisenberg limit (as $\text{Im}\varphi \rightarrow 0$)

$$(\mathcal{F}^{-1})_{\mu\nu} \rightarrow \frac{1}{N^2}$$

$$\widehat{W}_\varphi = \exp(-i\varphi\hat{\sigma}_z/2), \varphi \in \mathbb{C}$$

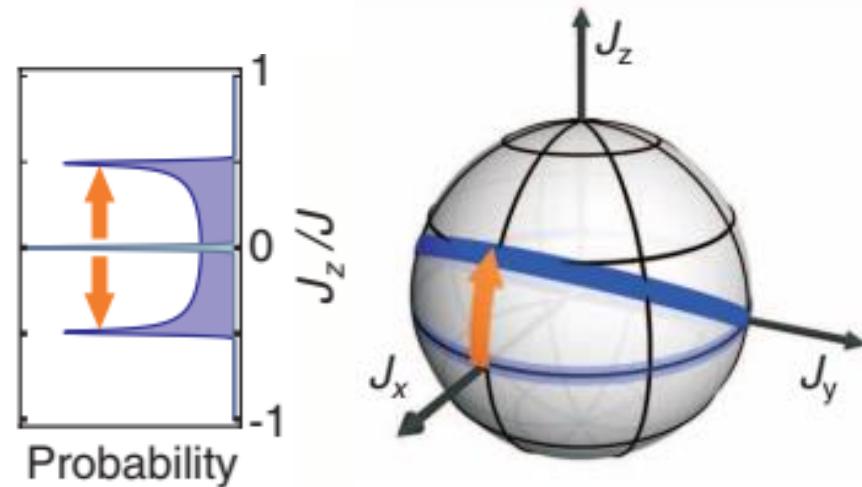
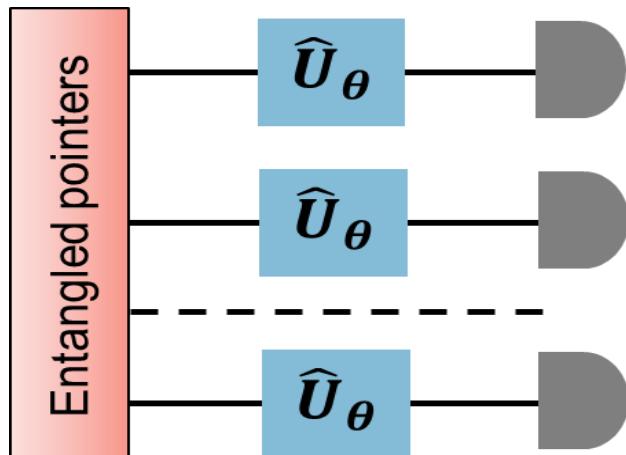
Can be proved by two measurements

$$\langle \sigma_z^{\otimes N} \rangle = \tanh(N\text{Im}\varphi), \quad \langle \sigma_x^{\otimes N} \rangle = \frac{\cos(N\text{Re}\varphi)}{\cosh(N\text{Im}\varphi)}$$

$$(\Delta\text{Re}\varphi)^2 = (\Delta\text{Im}\varphi)^2 = \frac{\cosh^2(N\text{Im}\varphi)}{N^2} \rightarrow \frac{1}{N^2} \text{ as } N\text{Im}\varphi \rightarrow 0$$

3. ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 1b: Pointers are in Dicke state $|\phi_{in}\rangle = |j, 0\rangle$, $j = N/2$ integer



Measure \hat{J}_z^2 to attain Heisenberg limit in estimate rotation θ

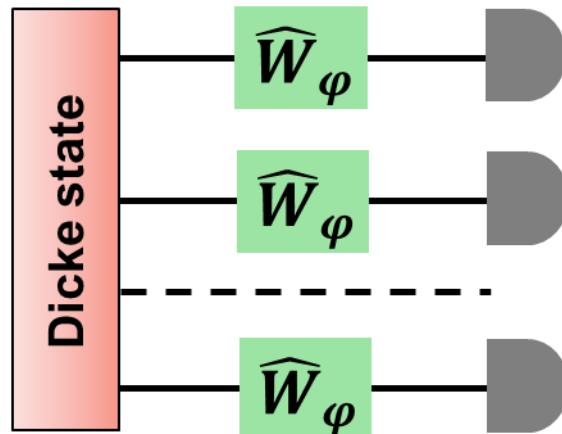
Symmetric Dicke state

$$|D_{N,N/2}\rangle := |j_{=N/2}, 0\rangle = \frac{j!}{\sqrt{N}} \sum_P \hat{P} |\underbrace{00\dots}_j \underbrace{11\dots}_j \rangle \rightarrow |\phi_{out}\rangle = e^{-i\theta \hat{J}_y} |j, 0\rangle$$

Lücke et al. (Science 2011), Apellaniz et al. (New J. Phys. 2015)

3. ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 1b: Pointers are in Dicke state $|\Phi_{in}\rangle = |j, 0\rangle$, $j = N/2$ integer



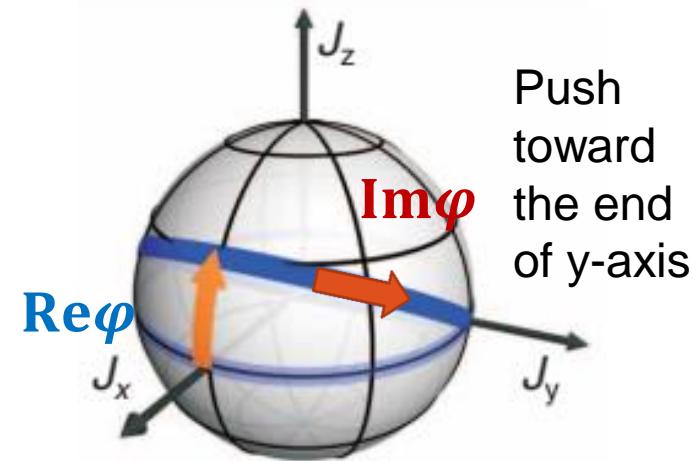
$$\widehat{W}_\varphi = \exp(-i\varphi\hat{\sigma}_y/2), \varphi \in \mathbb{C}$$

Measure $\hat{J}_z^2 \rightarrow \text{Re}\varphi$

Measure $\hat{J}_y \rightarrow \text{Im}\varphi$

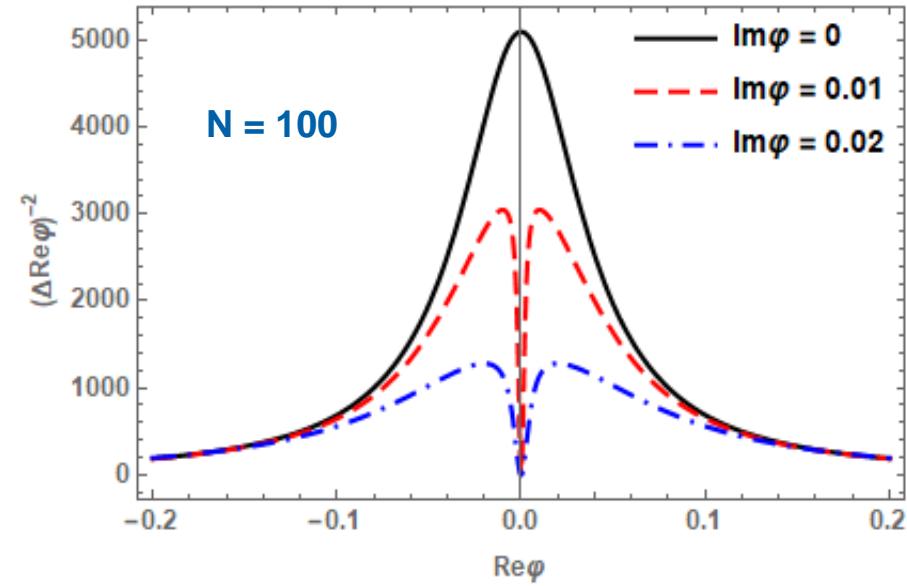
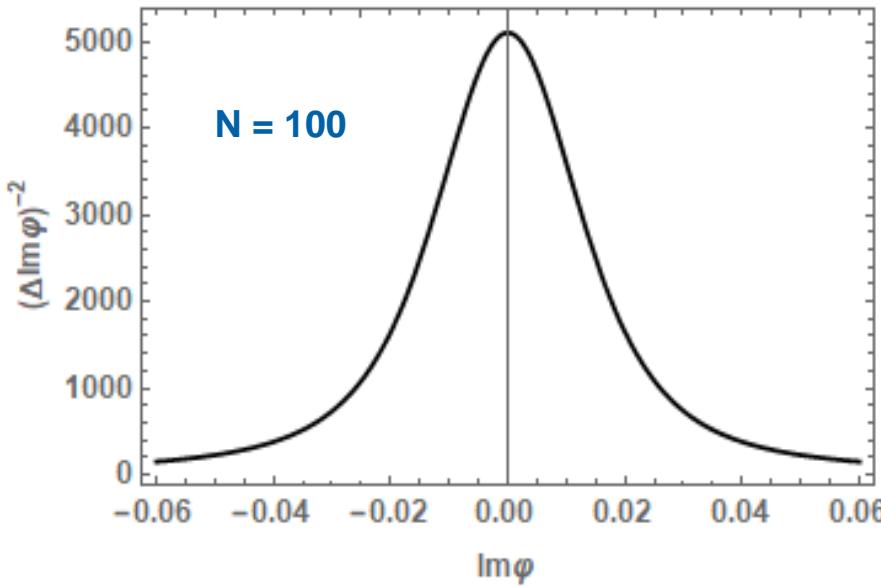
Final pointer

$$|\Phi_f\rangle_{\text{Dicke}} \propto e^{i\text{Im}\varphi\hat{J}_y} e^{-i\text{Re}\varphi\hat{J}_y} |j, 0\rangle$$



3. ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 1b: Pointers are in Dicke state $|\phi_{in}\rangle = |j, 0\rangle$, $j = N/2$ integer



$$\text{Im} \varphi \rightarrow 0: (\Delta \text{Im} \varphi)^2 \rightarrow \frac{2}{N(N+2)}$$

$$\varphi \rightarrow 0: (\Delta \text{Re} \varphi)^2 \rightarrow \frac{2}{N(N+2)}$$

Approaching Heisenberg limit

ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Pointers are entangled → Attainable Heisenberg limit
in even complex-valued parameter estimate

N00N state pointers

$$\langle \sigma_z^{\otimes N} \rangle = \tanh(N \operatorname{Im} \varphi), \quad \langle \sigma_x^{\otimes N} \rangle = \frac{\cos(N \operatorname{Re} \varphi)}{\cosh(N \operatorname{Im} \varphi)}$$

Dicke state pointers

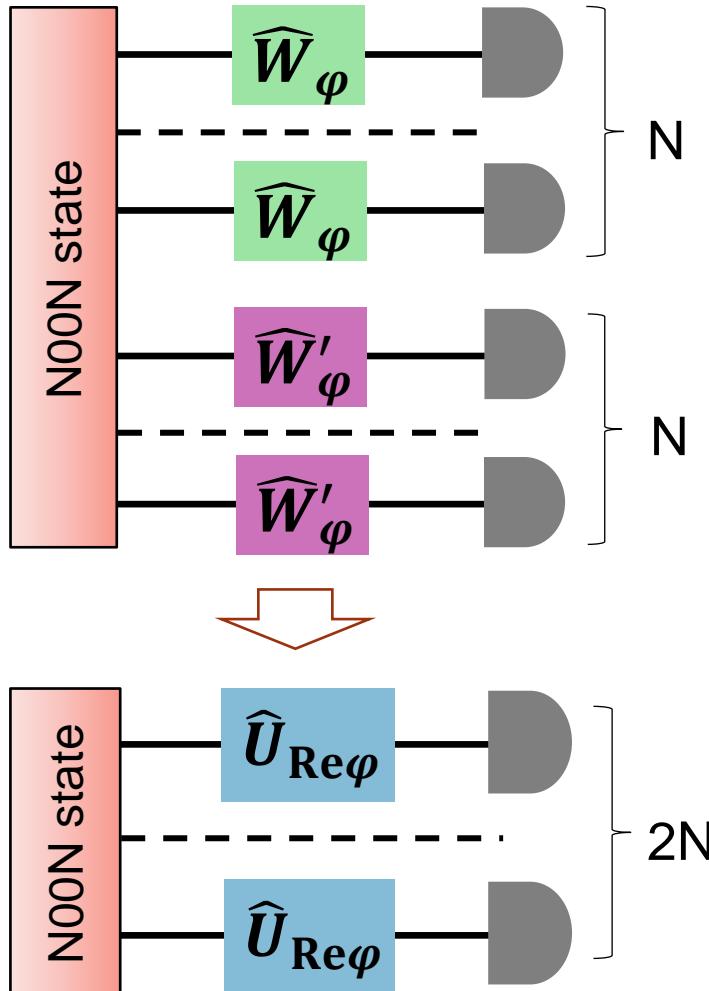
$$\langle \hat{J}_y \rangle = \frac{\operatorname{id}_{10}^{(j)}(2i \operatorname{Im} \varphi)}{\operatorname{d}_{10}^{(j)}(2i \operatorname{Im} \varphi)} \sqrt{j(j+1)}$$

$$\langle \hat{J}_z^2 \rangle = \frac{\operatorname{id}_{10}^{(j)}(2i \operatorname{Im} \varphi)}{\operatorname{d}_{10}^{(j)}(2i \operatorname{Im} \varphi)} \sqrt{j(j+1)} \left[\coth(2\operatorname{Im} \varphi) \sin^2 \varphi + \frac{i}{2} \sin(2\varphi) \right]$$

Can we extract the only real part of φ ?

ULTIMATE PRECISION OF DIRECT TOMOGRAPHY

Scheme 2: Time-inversal symmetry system ensemble



$$\widehat{W}_\varphi = \langle p_0 | \widehat{U}_x(\theta) | \psi_S \rangle$$

$$\widehat{W}'_\varphi = \langle p_0 | \widehat{U}_x(\theta) | \bar{\psi}_S \rangle$$

$$|\bar{\psi}_S\rangle := \widehat{T}|\psi_S\rangle = \sum_{x=1}^d \psi_x^*|x\rangle$$

\widehat{T} : Time-reversal symmetry operator

$$|\phi_f\rangle_{\text{TRS}} = \frac{|0\rangle^{\otimes 2N} + e^{i2N\text{Re}\varphi}|1\rangle^{\otimes 2N}}{\sqrt{2}}$$

$$\rightarrow (\Delta \text{Re}\varphi)^2 = \frac{1}{4N^2} \quad \text{Heisenberg limit}$$

SUMMARY

- Direct tomography (no weak-coupling approximation) as a **parameter estimation** → **optimal measurements**
- Direct tomography attainable the **Heisenberg limit**:
 - Scheme 1: using **maximally entangled pointers**
 - Scheme 2: using **time-reversal symmetry system ensemble**